## MC10E141

## 5 V ECL 8-Bit Shift Register

## Description

The MC10E/100E141 is an 8-bit full-function shift register. The E141 performs serial/parallel in and serial/parallel out, shifting in either direction. The eight inputs $\mathrm{D}_{0}-\mathrm{D}_{7}$ accept parallel input data, while DL/DR accept serial input data for left/right shifting. The Qn outputs do not need to be terminated for the shift operation to function. To minimize noise and power, any Q output not used should be left unterminated.

The select pins, SEL0 and SEL1, select one of four modes of operation: Load, Hold, Shift Left, Shift Right, according to the Function Table.

Input data is accepted a set-up time before the positive clock edge. A HIGH on the Master Reset (MR) pin asynchronously resets all the registers to zero.

The 100 Series contains temperature compensation.

## Features

- 700 MHz Min. Shift Frequency
- 8-Bit
- Full-Function, Bi-Directional
- Asynchronous Master Reset
- Pin-Compatible with E241
- PECL Mode Operating Range: $\mathrm{V}_{\mathrm{CC}}=4.2 \mathrm{~V}$ to 5.7 V with $\mathrm{V}_{\mathrm{EE}}=0 \mathrm{~V}$
- NECL Mode Operating Range: $\mathrm{V}_{\mathrm{CC}}=0 \mathrm{~V}$
with $\mathrm{V}_{\mathrm{EE}}=-4.2 \mathrm{~V}$ to -5.7 V
- Internal Input $50 \mathrm{k} \Omega$ Pulldown Resistors
- ESD Protection:
- > 2 kV Human Body Model
- > 200 V Machine Model
- Meets or Exceeds JEDEC Standard EIA/JESD78 IC Latchup Test
- Moisture Sensitivity: Level 3 (Pb-Free)
(For Additional Information, see Application Note AND8003/D)
- Flammability Rating: UL 94 V-0 @ 0.125 in,

Oxygen Index: 28 to 34

- Transistor Count $=565$ Devices
- These Devices are Pb-Free, Halogen Free and are RoHS Compliant

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PLCC-28
FN SUFFIX
CASE 776-02

*For additional marking information, refer to Application Note AND8002/D.

## ORDERING INFORMATION

| Device | Package | Shipping $\dagger$ |
| :--- | :---: | :---: |
| MC10E141FNG | PLCC-28 <br> (Pb-Free) | 37 Units / Tube |
| MC10E141FNR2G | PLCC-28 <br> (Pb-Free) | 500 Tape \& Reel |

$\dagger$ For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specifications Brochure, BRD8011/D.


* All $\mathrm{V}_{\mathrm{CC}}$ and $\mathrm{V}_{\mathrm{CCO}}$ pins are tied together on the die.

Warning: All $\mathrm{V}_{\mathrm{CC}}, \mathrm{V}_{\mathrm{CCO}}$, and $\mathrm{V}_{\mathrm{EE}}$ pins must be externally connected to Power Supply to guarantee proper operation.

Table 1. PIN DESCRIPTION

| PIN | FUNCTION |
| :--- | :--- |
| $D_{0}-D_{7}$ | ECL Parallel Data Inputs |
| $D^{2}, D R$ | ECL Serial Data Inputs |
| SELO, SEL1 | ECL Mode Select In Inputs |
| CLK | ECL Clock |
| $Q_{0}-Q_{7}$ | ECL Data Outputs |
| MR | ECL Master Reset |
| $V_{\text {CC }}, V_{C C O}$ | Positive Supply* |
| $V_{\text {EE }}$ | Negative Supply |
| NC | No Connect |

*From $V_{\text {CC }}$ pin to each $\mathrm{V}_{\mathrm{CCO}}$ pin is an internal $100 \Omega$ resistor.

Table 2. FUNCTION TABLE

| SEL0 | SEL1 | FUNCTION |
| :--- | :--- | :--- |
| L | L | Load |
| L | H | Shift Right $\left(D_{n}\right.$ to $\left.D_{n+1}\right)$ |
| H | L | Shift Left $\left(D_{n}\right.$ to $\left.D_{n-1}\right)$ |
| H | H | Hold |

Figure 1. 28-Lead Pinout


Figure 2. Logic Diagram
Table 3. EXPANDED FUNCTION TABLE

| Function | DL | DR | SEL0 | SEL1 | MR | CLK | Q0 | Q1 | Q2 | Q3 | Q4 | Q5 | Q6 | Q7 |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
| Load | X | X | L | L | L | Z | D0 | D1 | D2 | D3 | D4 | D5 | D6 | D7 |
| Shift Right | X | L | L | H | L | Z | L | Q0 | Q1 | Q2 | Q3 | Q4 | Q5 | Q6 |
|  | X | H | L | H | L | Z | H | L | Q0 | Q1 | Q2 | Q3 | Q4 | Q5 |
| Shift Left | L | X | H | L | L | Z | L | Q0 | Q1 | Q2 | Q3 | Q4 | Q5 | L |
|  | H | X | H | L | L | Z | Q0 | Q1 | Q2 | Q3 | Q4 | Q5 | L | H |
| Hold | X | X | H | H | L | Z | Q0 | Q1 | Q2 | Q3 | Q4 | Q5 | L | H |
|  | X | X | H | H | L | Z | Q0 | Q1 | Q2 | Q3 | Q4 | Q5 | L | H |
| Reset | X | X | X | X | H | X | L | L | L | L | L | L | L | L |

## MC10E141

Table 4. MAXIMUM RATINGS

| Symbol | Parameter | Condition 1 | Condition 2 | Rating | Unit |
| :---: | :---: | :---: | :---: | :---: | :---: |
| $\mathrm{V}_{\mathrm{CC}}$ | PECL Mode Power Supply | $\mathrm{V}_{\mathrm{EE}}=0 \mathrm{~V}$ |  | 8 | V |
| $\mathrm{V}_{\mathrm{EE}}$ | NECL Mode Power Supply | $\mathrm{V}_{\text {CC }}=0 \mathrm{~V}$ |  | -8 | V |
| $\mathrm{V}_{1}$ | PECL Mode Input Voltage NECL Mode Input Voltage | $\begin{aligned} & \mathrm{V}_{\mathrm{EE}}=0 \mathrm{~V} \\ & \mathrm{~V}_{\mathrm{CC}}=0 \mathrm{~V} \end{aligned}$ | $\begin{aligned} & \mathrm{V}_{1} \leq \mathrm{V}_{\mathrm{CC}} \\ & \mathrm{~V}_{\mathrm{I}} \geq \mathrm{V}_{\mathrm{EE}} \end{aligned}$ | $\begin{gathered} \hline 6 \\ -6 \end{gathered}$ | V |
| $\mathrm{I}_{\text {out }}$ | Output Current | Continuous |  | $\begin{gathered} 50 \\ 100 \end{gathered}$ | mA |
| $\mathrm{T}_{\mathrm{A}}$ | Operating Temperature Range |  |  | 0 to +85 | ${ }^{\circ} \mathrm{C}$ |
| $\mathrm{T}_{\text {stg }}$ | Storage Temperature Range |  |  | -65 to +150 | ${ }^{\circ} \mathrm{C}$ |
| $\theta_{\text {JA }}$ | Thermal Resistance (Junction-to-Ambient) | $\begin{array}{\|l\|} \hline 0 \text { lfpm } \\ 500 \text { lfpm } \end{array}$ | $\begin{aligned} & \text { PLCC-28 } \\ & \text { PLCC-28 } \end{aligned}$ | $\begin{aligned} & 63.5 \\ & 43.5 \end{aligned}$ | ${ }^{\circ} \mathrm{C} / \mathrm{W}$ |
| $\theta_{\text {Jc }}$ | Thermal Resistance (Junction-to-Case) | Standard Board | PLCC-28 | 22 to 26 | ${ }^{\circ} \mathrm{C} / \mathrm{W}$ |
| $\mathrm{V}_{\mathrm{EE}}$ | PECL Operating Range NECL Operating Range |  |  | $\begin{gathered} 4.2 \text { to } 5.7 \\ -5.7 \text { to }-4.2 \end{gathered}$ | V |
| $\mathrm{T}_{\text {sol }}$ | Wave Solder (Pb-Free) |  |  | $\begin{aligned} & 265 \\ & 265 \end{aligned}$ | ${ }^{\circ} \mathrm{C}$ |

Table 5. 10E SERIES PECL DC CHARACTERISTICS $\left(\mathrm{V}_{\mathrm{CCx}}=5.0 \mathrm{~V} ; \mathrm{V}_{\mathrm{EE}}=0.0 \mathrm{~V}\right.$ (Note 1))

| Symbol | Characteristic | $0^{\circ} \mathrm{C}$ |  |  | $25^{\circ} \mathrm{C}$ |  |  | $85^{\circ} \mathrm{C}$ |  |  | Unit |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  |  | Min | Typ | Max | Min | Typ | Max | Min | Typ | Max |  |
| $\mathrm{I}_{\text {EE }}$ | Power Supply Current |  | 131 | 181 |  | 131 | 181 |  | 131 | 181 | mA |
| $\mathrm{V}_{\mathrm{OH}}$ | Output HIGH Voltage (Note 2) | 3980 | 4070 | 4160 | 4020 | 4105 | 4190 | 4090 | 4185 | 4280 | mV |
| VOL | Output LOW Voltage (Note 2) | 3050 | 3210 | 3370 | 3050 | 3210 | 3370 | 3050 | 3227 | 3405 | mV |
| $\mathrm{V}_{\mathrm{IH}}$ | Input HIGH Voltage | 3830 | 3995 | 4160 | 3870 | 4030 | 4190 | 3940 | 4110 | 4280 | mV |
| $\mathrm{V}_{\mathrm{IL}}$ | Input LOW Voltage | 3050 | 3285 | 3520 | 3050 | 3285 | 3520 | 3050 | 3302 | 3555 | mV |
| $\mathrm{IIH}^{\text {H }}$ | Input HIGH Current |  |  | 150 |  |  | 150 |  |  | 150 | $\mu \mathrm{A}$ |
| IIL | Input LOW Current | 0.5 | 0.3 |  | 0.5 | 0.25 |  | 0.3 | 0.2 |  | $\mu \mathrm{A}$ |

NOTE: Device will meet the specifications after thermal equilibrium has been established when mounted in a test socket or printed circuit board with maintained transverse airflow greater than 500 lfpm. Electrical parameters are guaranteed only over the declared operating temperature range. Functional operation of the device exceeding these conditions is not implied. Device specification limit values are applied individually under normal operating conditions and not valid simultaneously.

1. Input and output parameters vary $1: 1$ with $\mathrm{V}_{\mathrm{CC}}$. $\mathrm{V}_{\mathrm{EE}}$ can vary $-0.46 \mathrm{~V} /+0.06 \mathrm{~V}$.
2. Outputs are terminated through a $50 \Omega$ resistor to $\mathrm{V}_{\mathrm{CC}}-2.0 \mathrm{~V}$.

Table 6. 10E SERIES NECL DC CHARACTERISTICS $\left(\mathrm{V}_{C C x}=0.0 \mathrm{~V} ; \mathrm{V}_{\mathrm{EE}}=-5.0 \mathrm{~V}\right.$ (Note 1))

| Symbol | Characteristic | $0^{\circ} \mathrm{C}$ |  |  | $25^{\circ} \mathrm{C}$ |  |  | $85^{\circ} \mathrm{C}$ |  |  | Unit |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  |  | Min | Typ | Max | Min | Typ | Max | Min | Typ | Max |  |
| $\mathrm{I}_{\text {EE }}$ | Power Supply Current |  | 131 | 181 |  | 131 | 181 |  | 131 | 181 | mA |
| $\mathrm{V}_{\mathrm{OH}}$ | Output HIGH Voltage (Note 2) | -1020 | -930 | -840 | -980 | -895 | -810 | -910 | -815 | -720 | mV |
| $\mathrm{V}_{\text {OL }}$ | Output LOW Voltage (Note 2) | -1950 | -1790 | -1630 | -1950 | -1790 | -1630 | -1950 | -1773 | -1595 | mV |
| $\mathrm{V}_{\mathrm{IH}}$ | Input HIGH Voltage | -1170 | -1005 | -840 | -1130 | -970 | -810 | -1060 | -890 | -720 | mV |
| $\mathrm{V}_{\mathrm{IL}}$ | Input LOW Voltage | -1950 | -1715 | -1480 | -1950 | -1715 | -1480 | -1950 | -1698 | -1445 | mV |
| $\mathrm{IIH}^{\text {H }}$ | Input HIGH Current |  |  | 150 |  |  | 150 |  |  | 150 | $\mu \mathrm{A}$ |
| IIL | Input LOW Current | 0.5 | 0.3 |  | 0.5 | 0.065 |  | 0.3 | 0.2 |  | $\mu \mathrm{A}$ |

NOTE: Device will meet the specifications after thermal equilibrium has been established when mounted in a test socket or printed circuit board with maintained transverse airflow greater than 500 Ifpm. Electrical parameters are guaranteed only over the declared operating temperature range. Functional operation of the device exceeding these conditions is not implied. Device specification limit values are applied individually under normal operating conditions and not valid simultaneously.

1. Input and output parameters vary $1: 1$ with $\mathrm{V}_{\mathrm{CC}}$. $\mathrm{V}_{\mathrm{EE}}$ can vary $-0.46 \mathrm{~V} /+0.06 \mathrm{~V}$.
2. Outputs are terminated through a $50 \Omega$ resistor to $\mathrm{V}_{\mathrm{CC}}-2.0 \mathrm{~V}$.

Table 7. 100E SERIES PECL DC CHARACTERISTICS $\left(\mathrm{V}_{\mathrm{CCx}}=5.0 \mathrm{~V} ; \mathrm{V}_{\mathrm{EE}}=0.0 \mathrm{~V}\right.$ (Note 1))

| Symbol | Characteristic | $0^{\circ} \mathrm{C}$ |  |  | $25^{\circ} \mathrm{C}$ |  |  | $85^{\circ} \mathrm{C}$ |  |  | Unit |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  |  | Min | Typ | Max | Min | Typ | Max | Min | Typ | Max |  |
| $\mathrm{I}_{\text {EE }}$ | Power Supply Current |  | 131 | 181 |  | 131 | 181 |  | 151 | 181 | mA |
| $\mathrm{V}_{\mathrm{OH}}$ | Output HIGH Voltage (Note 2) | 3975 | 4050 | 4120 | 3975 | 4050 | 4120 | 3975 | 4050 | 4120 | mV |
| $\mathrm{V}_{\text {OL }}$ | Output LOW Voltage (Note 2) | 3190 | 3295 | 3380 | 3190 | 3255 | 3380 | 3190 | 3260 | 3380 | mV |
| $\mathrm{V}_{\mathrm{IH}}$ | Input HIGH Voltage | 3835 | 3975 | 4120 | 3835 | 3975 | 4120 | 3835 | 3975 | 4120 | mV |
| $\mathrm{V}_{\mathrm{IL}}$ | Input LOW Voltage | 3190 | 3355 | 3525 | 3190 | 3355 | 3525 | 3190 | 3355 | 3525 | mV |
| $\mathrm{IIH}^{\text {I }}$ | Input HIGH Current |  |  | 150 |  |  | 150 |  |  | 150 | $\mu \mathrm{A}$ |
| IIL | Input LOW Current | 0.5 | 0.3 |  | 0.5 | 0.25 |  | 0.5 | 0.2 |  | $\mu \mathrm{A}$ |

NOTE: Device will meet the specifications after thermal equilibrium has been established when mounted in a test socket or printed circuit board with maintained transverse airflow greater than 500 Ifpm. Electrical parameters are guaranteed only over the declared operating temperature range. Functional operation of the device exceeding these conditions is not implied. Device specification limit values are applied individually under normal operating conditions and not valid simultaneously.

1. Input and output parameters vary $1: 1$ with $\mathrm{V}_{\mathrm{CC}}$. $\mathrm{V}_{\text {EE }}$ can vary $-0.46 \mathrm{~V} /+0.8 \mathrm{~V}$.
2. Outputs are terminated through a $50 \Omega$ resistor to $\mathrm{V}_{\mathrm{CC}}-2.0 \mathrm{~V}$.

Table 8. 100E SERIES NECL DC CHARACTERISTICS $\left(\mathrm{V}_{\mathrm{CCx}}=0.0 \mathrm{~V} ; \mathrm{V}_{\mathrm{EE}}=-5.0 \mathrm{~V}\right.$ (Note 1))

| Symbol | Characteristic | $0^{\circ} \mathrm{C}$ |  |  | $25^{\circ} \mathrm{C}$ |  |  | $85^{\circ} \mathrm{C}$ |  |  | Unit |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  |  | Min | Typ | Max | Min | Typ | Max | Min | Typ | Max |  |
| $\mathrm{I}_{\text {EE }}$ | Power Supply Current |  | 131 | 181 |  | 131 | 181 |  | 151 | 181 | mA |
| $\mathrm{V}_{\mathrm{OH}}$ | Output HIGH Voltage (Note 2) | -1025 | -950 | -880 | -1025 | -950 | -880 | -1025 | -950 | -880 | mV |
| $\mathrm{V}_{\text {OL }}$ | Output LOW Voltage (Note 2) | -1810 | -1705 | -1620 | -1810 | -1745 | -1620 | -1810 | -1740 | -1620 | mV |
| $\mathrm{V}_{\mathrm{IH}}$ | Input HIGH Voltage | -1165 | -1025 | -880 | -1165 | -1025 | -880 | -1165 | -880 | -1025 | mV |
| $\mathrm{V}_{\text {IL }}$ | Input LOW Voltage | -1810 | -1645 | -1475 | -1810 | -1645 | -1475 | -1810 | -1475 | -1645 | mV |
| $\mathrm{IIH}^{\text {H }}$ | Input HIGH Current |  |  | 150 |  |  | 150 |  |  | 150 | $\mu \mathrm{A}$ |
| IIL | Input LOW Current | 0.5 | 0.3 |  | 0.5 | 0.25 |  | 0.5 | 0.2 |  | $\mu \mathrm{A}$ |

NOTE: Device will meet the specifications after thermal equilibrium has been established when mounted in a test socket or printed circuit board with maintained transverse airflow greater than 500 lfpm. Electrical parameters are guaranteed only over the declared operating temperature range. Functional operation of the device exceeding these conditions is not implied. Device specification limit values are applied individually under normal operating conditions and not valid simultaneously.

1. Input and output parameters vary $1: 1$ with $\mathrm{V}_{\mathrm{CC}}$. $\mathrm{V}_{\mathrm{EE}}$ can vary $-0.46 \mathrm{~V} /+0.8 \mathrm{~V}$.
2. Outputs are terminated through a $50 \Omega$ resistor to $\mathrm{V}_{\mathrm{CC}}-2.0 \mathrm{~V}$.

Table 9. AC CHARACTERISTICS $\left(\mathrm{V}_{C C x}=5.0 \mathrm{~V} ; \mathrm{V}_{\mathrm{EE}}=0.0 \mathrm{~V}\right.$ or $\mathrm{V}_{\mathrm{CCx}}=0.0 \mathrm{~V} ; \mathrm{V}_{\mathrm{EE}}=-5.0 \mathrm{~V}$ (Note 1))

| Symbol | Characteristic | $0^{\circ} \mathrm{C}$ |  |  | $25^{\circ} \mathrm{C}$ |  |  | $85^{\circ} \mathrm{C}$ |  |  | Unit |
| :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: | :---: |
|  |  | Min | Typ | Max | Min | Typ | Max | Min | Typ | Max |  |
| $\mathrm{f}_{\text {SHIFT }}$ | Max. Shift Frequency | 700 | 900 |  | 700 | 900 |  | 700 | 900 |  | MHz |
| $\begin{gathered} \mathrm{tPLH}^{\mathrm{t}} \\ \mathrm{PHL} \end{gathered}$ | Propagation Delay To Output Clk MR | $\begin{aligned} & 625 \\ & 600 \end{aligned}$ | $\begin{aligned} & 750 \\ & 725 \end{aligned}$ | $\begin{aligned} & 975 \\ & 975 \end{aligned}$ | $\begin{aligned} & 625 \\ & 600 \end{aligned}$ | $\begin{aligned} & 750 \\ & 725 \end{aligned}$ | $\begin{aligned} & 975 \\ & 975 \end{aligned}$ | $\begin{aligned} & 625 \\ & 600 \end{aligned}$ | $\begin{aligned} & 750 \\ & 725 \end{aligned}$ | $\begin{aligned} & 975 \\ & 975 \end{aligned}$ | ps |
| $\mathrm{t}_{\text {s }}$ | Setup Time D SELO SEL1 | $\begin{aligned} & 175 \\ & 350 \\ & 300 \end{aligned}$ | $\begin{gathered} 25 \\ 200 \\ 150 \end{gathered}$ |  | $\begin{aligned} & 175 \\ & 350 \\ & 300 \end{aligned}$ | $\begin{gathered} 25 \\ 200 \\ 150 \end{gathered}$ |  | $\begin{aligned} & 175 \\ & 350 \\ & 300 \end{aligned}$ | $\begin{aligned} & 25 \\ & 200 \\ & 150 \end{aligned}$ |  | ps |
| $t_{\text {h }}$ | ```Hold Time D SELO SEL1``` | $\begin{aligned} & 200 \\ & 100 \\ & 100 \end{aligned}$ | $\begin{aligned} & -25 \\ & -200 \\ & -150 \end{aligned}$ |  | $\begin{aligned} & 200 \\ & 100 \\ & 100 \end{aligned}$ | $\begin{aligned} & -25 \\ & -200 \\ & -150 \end{aligned}$ |  | $\begin{aligned} & 200 \\ & 100 \\ & 100 \end{aligned}$ | $\begin{aligned} & -25 \\ & -200 \\ & -150 \end{aligned}$ |  | ps |
| $\mathrm{t}_{\mathrm{RR}}$ | Reset Recovery Time | 900 | 700 |  | 900 | 700 |  | 900 | 700 |  | ps |
| tPW | Minimum Pulse Width Clk, MR | 400 |  |  | 400 |  |  | 400 |  |  | ps |
| ${ }^{\text {tskEw }}$ | Within-Device Skew (Note 2) |  | 60 |  |  | 60 |  |  | 60 |  | ps |
| $\mathrm{t}_{\text {JITTER }}$ | Random Clock Jitter (RMS) |  | <1 |  |  | <1 |  |  | <1 |  | ps |
| $\begin{aligned} & \mathrm{t}_{\mathrm{r}} \\ & \mathrm{t}_{\mathrm{f}} \end{aligned}$ | Rise/Fall Times (20-80\%) | 300 | 525 | 800 | 300 | 525 | 800 | 300 | 525 | 800 | ps |

NOTE: Device will meet the specifications after thermal equilibrium has been established when mounted in a test socket or printed circuit board with maintained transverse airflow greater than 500 lfpm. Electrical parameters are guaranteed only over the declared operating temperature range. Functional operation of the device exceeding these conditions is not implied. Device specification limit values are applied individually under normal operating conditions and not valid simultaneously.

1. 10 Series: $\mathrm{V}_{\text {EE }}$ can vary $-0.46 \mathrm{~V} /+0.06 \mathrm{~V}$.

100 Series: $\mathrm{V}_{\text {EE }}$ can vary $-0.46 \mathrm{~V} /+0.8 \mathrm{~V}$.
2. Within-device skew is defined as identical transitions on similar paths through a device.

## MC10E141



Figure 3. Typical Termination for Output Driver and Device Evaluation (See Application Note AND8020/D - Termination of ECL Logic Devices)

Resource Reference of Application Notes
AN1405/D - ECL Clock Distribution Techniques
AN1406/D - Designing with PECL (ECL at +5.0 V)
AN1503/D - ECLinPS $^{\text {M }}$ I/O SPiCE Modeling Kit
AN1504/D - Metastability and the ECLinPS Family $^{\text {AN1568/D }}-$ Interfacing Between LVDS and ECL
AN1672/D - The ECL Translator Guide
AND8001/D - Odd Number Counters Design
AND8002/D - Marking and Date Codes
AND8020/D - Termination of ECL Logic Devices
AND8066/D - Interfacing with ECLinPS
AND8090/D - AC Characteristics of ECL Devices

## MC10E141

## PACKAGE DIMENSIONS

28 LEAD PLLC
FN SUFFIX
CASE 776-02
ISSUE F


NOTES:

1. DATUMS -L-, -M-, AND -N- DETERMINED WHERE TOPOF LEAD SHOULDER EXITS PLASTIC BODY AT MOLD PARTING LINE 2. DIMENSION G1, TRUE POSITION TO BE MEASURED AT DATUM -T-, SEATING PLANE.
DIMENSIONS R AND U DO NOT INCLUDE MOLD FLASH. ALLOWABLE MOLD FLASH IS 0.010 ( 0.250 ) PER SIDE.
2. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.
CONTROLLING DIMENSION: INCH
3. THE PACKAGE TOP MAY BE SMALLER THAN THE PACKAGE BOTTOM BY UP TO 0.012 (0.300). DIMENSIONS R AND U ARE O.jTERMINED AT THE OUTERMOST EXTREMES OF THE PLASTIC BODY EXTREMES OF THE PLASIIC BODY EXCLUSIVE OF MOLD FLASH, TIE BAR
BURRS, GATE BURRS AND INTERLEAD BURRS, GATE BURRS AND INTERLEAD
FLASH, BUT INCLUDING ANY MISMATCH FLASH, BUT INCLUDING ANY MISMATCH BETWEEN THE TOP AND BOTTOM OF THE PLASTIC BODY.
4. DIMENSION H DOES NOT INCLUDE DAMBAR PROTRUSION OR INTRUSION. THE DAMBAR PROTRUSION(S) SHALL NOT CAUSE THE H DIMENSION TO BE GREATER THAN 0.037 (0.940). THE DAMBAR INTRUSION(S) SHALL NOT CAUSE THE H DIMENSION TO BE SMALLER THAN 0.025 ( 0.635 ).

|  | INCHES |  | MILLIMETERS |  |
| :---: | :---: | :---: | ---: | ---: |
| DIM | MIN | MAX | MIN | MAX |
| A | 0.485 | 0.495 | 12.32 | 12.57 |
| B | 0.485 | 0.495 | 12.32 | 12.57 |
| C | 0.165 | 0.180 | 4.20 | 4.57 |
| E | 0.090 | 0.110 | 2.29 | 2.79 |
| F | 0.013 | 0.021 | 0.33 | 0.53 |
| G | 0.050 BSC |  | 1.27 |  |
| BSC |  |  |  |  |
| H | 0.026 | 0.032 | 0.66 | 0.81 |
| J | 0.020 | --- | 0.51 | --- |
| K | 0.025 | --- | 0.64 | --- |
| R | 0.450 | 0.456 | 11.43 | 11.58 |
| U | 0.450 | 0.456 | 11.43 | 11.58 |
| V | 0.042 | 0.048 | 1.07 | 1.21 |
| W | 0.042 | 0.048 | 1.07 | 1.21 |
| X | 0.042 | 0.056 | 1.07 | 1.42 |
| Y | --- | 0.020 | --- | 0.50 |
| Z | $2^{\circ}$ | $10^{\circ}$ | $2^{\circ}$ | $10^{\circ}$ |
| G1 | 0.410 | 0.430 | 10.42 | 10.92 |
| K1 | 0.040 | --- | 1.02 | --- |

## MC10E141

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#### Abstract

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